

Notice of References Cited		Application/Control No. 09/887,781	Applicant(s)/Patent Under Reexamination ANN ET AL.	
		Examiner Tan Dean D. Nguyen	Art Unit 3689	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,162,427	01-2007	Myrick et al.	705/1
*	B	US-6,697,824	02-2004	Bowman-Amuah, Michel K.	709/229
*	C	US-2004/0059611	03-2004	Kananghinis et al.	705/007
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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